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	WW	AA	6,114,346	09/05/2000			514	290			
		AB	6,265,414	07/24/2001			514	290			
		AC	6,599,913	07/29/2003			514	290			
	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	AD	6,423,721	07/23/2002			514	290			
	P	AE	6,054,463	04/25/2000	Handley, et a	al	514	290			
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.